

Direct Observation of Defect Range and Evolution in Ion-Irradiated Single Crystalline Ni and Ni Binary Alloys

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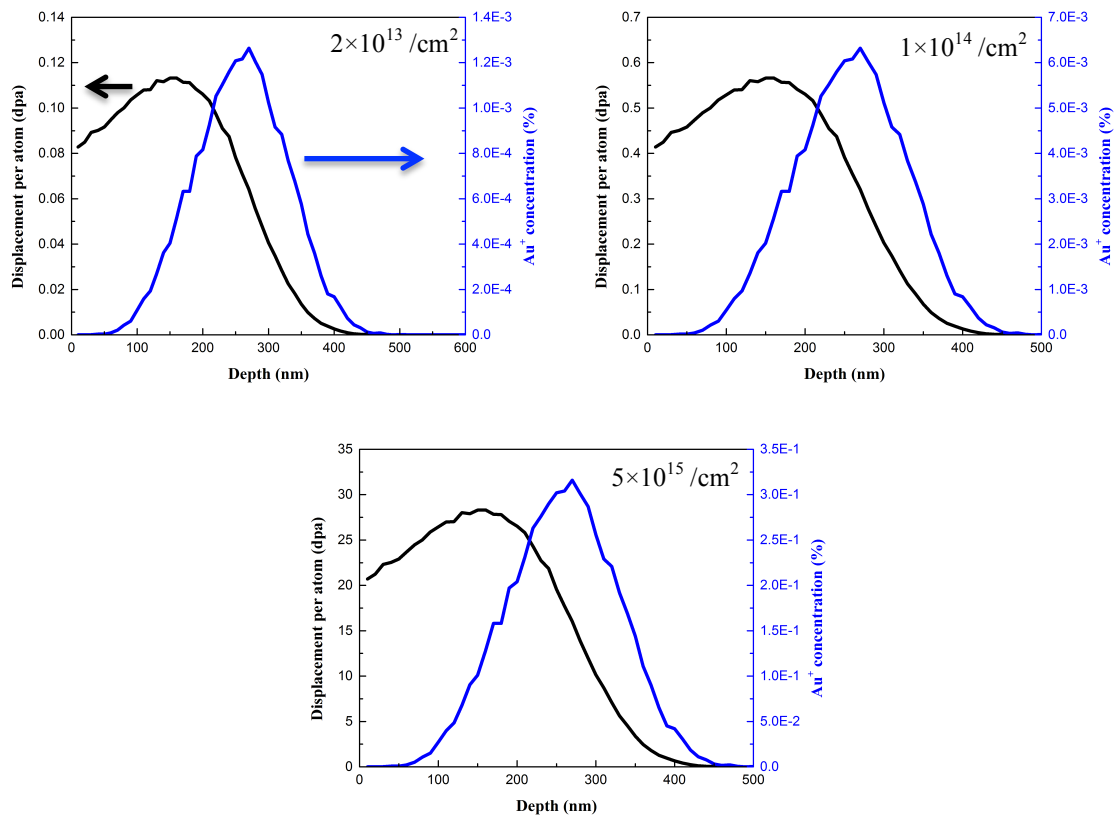
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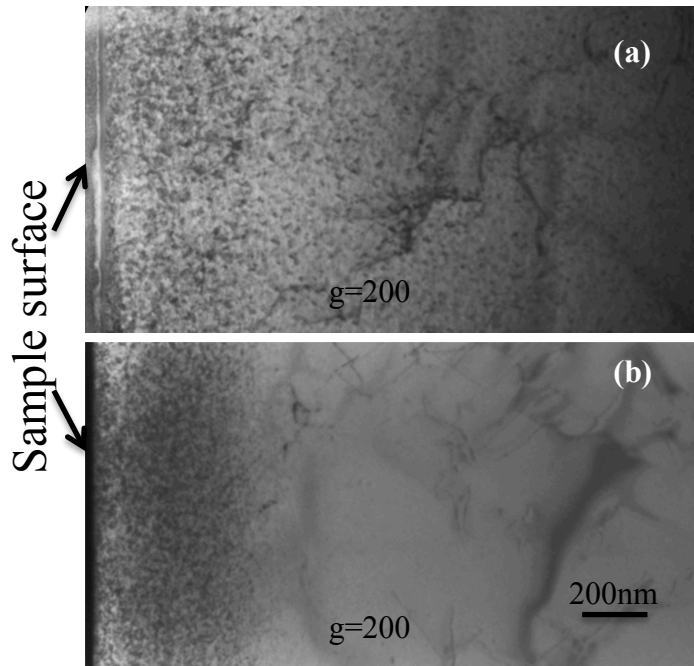
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Supplementary Figure S1. Predicted distributions of damage and Au concentration in pure Ni irradiated by 3 MeV Au ions to a fluence of (a) $2 \times 10^{13} / \text{cm}^2$; (b) $1 \times 10^{14} / \text{cm}^2$; (c) $5 \times 10^{15} / \text{cm}^2$.



Supplementary Figure S2. Bright-field TEM images of a NiCo sample before (a) and after (b) flash polishing following the lift-out procedure with a standard FIB technique, $g=[200]$. The sample was initially irradiated by a 3 MeV Au ion beam to $2 \times 10^{13} / \text{cm}^2$. As demonstrated in (a), FIB polishing introduced a lot of “black dot damages” in the TEM specimen, most of which were removed by flash polishing as shown in (b).

Supplementary Video S1. Two k-ART simulations were obtained by performing simulations of a 10 keV displacement cascade in Ni at 300 K (a) and 900 K (b). Notably, small vacancy clusters (di-vacancies, tri-vacancies) were found to be much more mobile than single vacancies.

Supplementary: Stress study. We have performed 4-circle X-ray diffraction (XRD) measurements at symmetric and asymmetric diffraction peaks of (111), (002) and (113), respectively. An irradiation-induced peak broadening is observed. As compared to the full width at half maximum (FWHM) of the omega-scan through the 002 peak of $\sim 0.1^\circ$ and 0.05° for the undamaged crystals, a peak width of $\sim 0.3^\circ$ and 0.4° is identified in the irradiated NiCo and NiFe samples, respectively. The lattice in these irradiated regions, however, remains fcc phase aligned with the underlying undamaged crystal. Moreover, we observe a broadening in the 2-theta direction, which may correspond to existence of extended defects (interstitial loops) and the expected non-uniform distribution of the Au substitution at this high fluence ($1.1 \times 10^{17} / \text{cm}^2$). Substitutional occupation of implanted Au ions is confirmed from ion channeling measurements on the same irradiated samples. We deduce from the XRD measurements an average lattice parameter expansion to 3.561 Å and 3.608 Å for NiCo and NiFe, as compared to the 3.533 Å and 3.589 Å for the corresponding undamaged crystals. The resulting range of 5% - 8% is in agreement with both the Au profile predicted from SRIM and measured from ion channeling technique.